E lectron transport of a quantum wire containing a nite-size impurity under THz electrom agnetic eld illum ination

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W e theoretically investigate the electron transport properties for a sem iconductor quantum wire containing a single nite-size attractive in purity under an external terahertz electrom agnetic eld illum ination in the ballistic lim it. W ithin the e ective mass free-electron approximation, the scattering matrix for the system has been formulated by means of a time-dependent mode matching m ethod. Som e interesting properties of the electron transm ission for the system have been shown through a few groups of num erical exam ples. It is found that in the case of the comparative stronger eld am plitude and the frequency resonant with the two lowest lateral energy levels in the impurity region, the eld-induced intersubband transition dominates the process as if without the impurity. And there is a step-arising on the transmission as a function of the incident electron energy. However, in the case of lower eld amplitude and the non-resonant frequencies both multiple symmetry B reit-type resonance peaks and asym metry Fano-type dip lines appear in the electron transmission dependence on the incident energy due to the presence of the impurity and the external eld. Therefore, within certain energy range the transmission as a function of the eld frequency and/or eld am plitude shows a rich structure. Moreover, the transmission dependence on the strength and size of the impurity is also discussed. It is suggested that these results mostly arise from the interplay e ects between the impurity in a quantum wire and the applied eld.

PACS numbers: 73.23.-b; 73.21.Hb; 78.67.Lt

I. INTRODUCTION

Quantum devices using a two-dimensional electron gas (2DEG) formed in high-mobility GaAs/Al $_{\rm k}$ Ga $_{\rm 1}$ $_{\rm x}$ As semiconductor heterostructure have been found to have better perform ance characteristics than bulk devices. It has been predicated that the characteristics of the devices may be further improved by using quantum wires in which the carriers behave as a quasi-one-dimensional gas. And some technological success has been achieved in recent years in growing high-quality semiconductor quantum wires with a length up to m $_{\rm s}$. In the ballistic regime and at low temperatures quantum coherent elects will dominate the electron transport properties of a mesoscopic system. One of the most important features is that, when the lateral size of a quantum wire varies, the conductance shows an histogram structure and each step has an height of $2e^2$ =h or integer times of it for both short wire (quantum point contact) and long wire.

The electron transport properties of the quantum wire formed on a 2DEG can be a ected by many factors. The presence of disorders in a quantum wire generally leads to a suppression of the conductance plateaus below integer values. Especially, for a quantum wire containing an attractive in purity the transmission shows resonance dips below each con nement subband. Also, the interaction of electrons induces transport anomalies. However, there has been growing interest in the time-dependent transport for quantum wire systems in recent years, such as presence of a time-modulated potential and quantum pumping. Further, when a quantum wire is illuminated under an external electromagnetic (EM) eld, due to the inelastic scattering of electrons by photons many new features have been observed experimentally and predicted theoretically. The technique of applying an external eld is of particular interest, since no additional current and voltage probes have to be attached to the sample which may disturb the system sproperties. More recently, a new type of giant magnetoresistance has been discovered and theoretically explained in a high-mobility 2DEG subject to a high frequency microwave radiation and a vertical magnetic eld. It is therefore of great interest in basic physics aspect to study the time-dependent transport properties of quantum structures on semiconductor 2DEG system. On the other hand, possible applications of nanostructures in future electronic devices, which will have to operate at very high frequencies, require detailed know ledge of their frequency-and time-dependent transport behavior.

The values of the lateral energy level separation and the Ferm i energy are of the order of 1 100m eV for the typical sem iconductor quantum wires. This corresponds to frequencies of the range of 0.25 25 terahertz (THz), which is

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available in experim ents with the developm ent of the ultrafast laser technology and the physics in this frequency range is of interest now. 18 W hen the Ferm i level is below the lowest lateral level at the bottleneck part of a quantum wire, electrons can not go through without the assistance of an external EM eld. However, under the eld illumination, electrons in the wire can absorb energy of photons and go through this geom etric barrier (the neck). Therefore, in the region of barrier the electron transm ission is determ ined by the combined e ect of the external EM eld and the wire lateral shape variation. 11 14 Recently, with an emphasis on the pure EM elde ect on the electron transport, we have theoretically investigated a straight (uniform cross-section) and clean (without in purity) quantum wire illuminated under a transversely polarized THz EM eld. An interesting transmission step-like structure has been predicated when the EM eld frequency is resonant with the two lowest lateral energy levels of the quantum wire. Also, the im purity e ect on the transport is in portant for a thin and long quantum wire because the electron interaction e ect is observable in the presence of backscattering. 1,13 W ithout considering this interaction, the resonance structures of the electron transmission in a straight quantum wire with a nite-size scatter for a wide range of the impurity parameters have been investigated in the absence of external EM eld. In the present paper, we combine the models in Refs. [7,19] and study the electron transm ission through a straight quantum wire containing a nite-size attractive in purity under a transversely polarized THzEM eld illum ination. In this case the transmission behavior may reject the interplay e ects between the impurity and the external EM eld19 on the electron transport. W ithin the e ective m ass freeelectron approximation, the scattering matrix for the system has been formulated through a time-dependent mode m atching method. 19 Using a group of numerical examples we demonstrate some interesting electron transmission behaviors for this system. To the best of our know ledge, the interplay e ect between the impurity and the external EM eld on the electron transport for a quantum wire has not been reported previously. This elect may be important for the understanding of basic physics in low-dimensional systems and for the future nanoscale circuit applications.

The outline of the paper is as follows. In Sec. II we set up the problem for a straight quantum wire containing a nite-size in purity under an external THzEM eld illumination in terms of a single-electron time-dependent Schrodinger equation, and calculate the electron transmission probability through the system by the time-dependent mode matching in the framework of Landauer-Buttiker formalism. Some numerical examples to illustrate the dependence of the electron transmission on the incident energy, eld parameters, and impurity parameters respectively are presented and discussed in Sec. III. Finally, Sec. IV gives a conclusion of the paper.

II. M ODEL AND FORM ALISM

The system under study is an ideal straight 2D quantum wire (quantum waveguide) of width D, containing a nite-size attractive in purity, which is depicted in Fig. 1 schematically. The quantum wire smoothly connects the two electron reservoirs (leads) at each end. The x-axis is longitudinally along the wire, and the y-axis describes the transverse direction. The impurity range 0 x lin the quantum wire is illuminated under a transversely polarized THzEM eld in an unspecified way. The eld vector potential can be described as $A = ("=!) \cos(!t) \hat{e}_y$ with angular frequency! and amplitude " (\hat{e}_y is the unit vector in the polarized direction).

W ithin an e ective mass approximation, the single-particle time-dependent Schrodinger equation in the eld illuminated impurity region is

$$i\frac{\theta}{\theta t}$$
 (x;y;t) = $\frac{\theta^2}{\theta x^2}$ + $(i\frac{\theta}{\theta y} + eA)^2 + v_c(y) + v_i(x;y)$ (x;y;t); (1)

where we have adopted the unit of h = 2m = 1. In the H am iltonian, $v_c(y)$ presents a transverse con ning potential in the form of either a hard-wall or parabolic one which con nes electrons to the wire and to the reservoirs, and

$$v_i(x;y) = (x) (1 x)v_i(y) = v(x) (1 x) (d=2 jy y j)$$
 (2)

is used to represent the single nite-size in purity potential, where v is the strength of the impurity and (x) is the step function (see Fig.1). This type of the nite-size single impurity has been used to model an unintentional Be doping in GaAs sem iconductor and may be articially created in the quantum waveguide using recent nanotechnology.

U sing the m ethod used in Ref.[19] (also see Ref.[20]) to solve the time-dependent Schroinger equation (1), and then considering the scattering of the two interfaces between the impurity region (with eld illumination) and the clean region (without eld illumination) separately. The detail knowledge about this aspects is referred to Refs.[19,20] and is not presented here.

When an electron with total incident energy E em its from the left reservoir to the left interface at x = 0, transmission and rejection will take place simultaneously. Because the electron has certain probability of absorbing a photon after penetrate the interface, transition from the lower mode to the upper mode happens. So there are two energy

components of E and E + h! in the rejected wave in the region of x < 0

$$(x;y;t) = [e^{i(k_1x - E t)} + c_1e^{i(k_1x + E t)}]_1(y) + c_2e^{i[k_2x + (E + !)t]}_2(y);$$
(3)

where $_n$ (y) (n=1,2) are transverse eigenfunctions with eigenvalues $_n$ in the clean region (without impurity), c_1 , c_2 are the re-ection coe cients of the two modes respectively, and

$$k_1 = p \frac{p}{E_{1}}, k_2 = p \frac{p}{E_{2} + 1}$$
 (4)

are their associated wavevectors. Consequently, we can obtain the electronic wavefunction in the region of x > 0

where $_n$ (y) and $_n^0$ are the solutions for the transverse equation with impurity potential v_i (y). c_+ , c_- are the transmission coe cients of the two eld-spilt modes and the constants $G_- = (0, 0, 0, 0)$ is the detuning, and is the two-mode coupling constant). The two electron wavevectors in the impurity region are

We can match the above two wavefunctions (3) and (5) at the interface of x = 0. Continuously connecting the two above wavefunctions and their dierentials gives the following four algebraical equations for the coexcients c_1 , c_2 , c_4 and c_4

where $_{nn^0} = \frac{R_{D=2}}{D=2} \, dy_n \, (y)_{n^0} \, (y)$ (n; n⁰ = 1;2) is the matrix elements for connecting the two sets of transverse eigenfunctions. With the solution of these algebraic equations in Eq. (7) both the transmission and the rejection matrix for the left interface (as if without the right interface) can be expressed by

$$t^{0} = p \frac{p}{k_{+} = k_{1}} \frac{c_{+}}{c} = 0 ; r = p \frac{c_{1}}{k_{2} = k_{1}} c_{2} = 0 :$$
 (8)

When we consider the electron transmission probability through the whole real impurity, we use the approach recently developed in Ref. [21] for the symmetric system. This approach needs to derive the total scattering matrix which can be expressed in the transmission matrix and rejection matrix on each interface. The total transmission matrix is just the anti-diagonal submatrix of the total scattering matrix in the symmetry system case.

Because of the sim ilarity of the two interfaces one has not to m atch the wave functions at the right interface x = 1, but we need to know the transm ission and rejection matrix of electron emitting from right to left for the left interface. In this case the electronic wavefunction in the impurity region is

$$(x;y;t) = [c_{+}^{e}e^{ik_{+}x} + c_{+}^{e}e^{ik_{-}x} + c_{+}^{r}e^{ik_{+}x} + c_{+}^{r}e^{ik_{-}x} + c_{+}^{r$$

where c^e are the coe cients of the electron em itting from right to left, c^r are the associated re ection coe cients. Correspondingly, the transmitted electron wavefunction in the region of x < 0 is

$$(x;y;t) = c_1^t e^{i(k_1x + Et)} _1(y) + c_2^t e^{i[k_2x + (E+!)t]} _2(y);$$
(10)

where c_1^t and c_2^t are the transm ission coe cients. These two wavefunctions also satisfy the continuous condition at x=0, from which we can obtain the transm ission and rejection matrix from right to left for this interface, r^0 and t, respectively (Here we do not present the detailed expressions for them because they are much more complicated than Eq. (8) for t^0 and r). Consequently, the total transm ission matrix through the two interfaces (the whole system) is $t_{tot}=S_{12}=t(1-X\,r^0\!X\,r^0\!)^{-1}\!X\,t^0$. Therefore, according to Landauer-Buttiker's formulation²² the total electron transm ission probability through the whole system is

$$T = Tr[t_{tot}^{y}t_{tot}]; (11)$$

where X is the transfer matrix between the two interfaces of the system. 19

III. RESULTS AND DISCUSSION

In this section, we numerically calculate the transmission probability from Eq. (12). The physical quantities of the system are chosen to be a high mobility GaAs/Al_xGa_{1-x}As heterostructure^{1;2} with a typical electron density $n=2.5-10^{11}$ cm⁻² and m=0.067 m_e (where m_e is the free electron mass). We choose the hard-wall transverse conning potential and the width of the wire D=500A (see Fig. 1) such that the unit of energy E=10 h²⁻²=(2m D²) = 14:1meV which corresponds to the unit of time $t=h=E=4:7-10^{-14}$ s. Correspondingly, the eld frequency unit! = 1=t = 21:3THz and the amplitude unit "= 22:1V/cm. This kind of radiation is available in experiments now. We have a larger than the length unit t=0=63:7A.

For the hard-wall con ning potential with a nite-size impurity of d=0:1D, l=25, $y_c=0:17D$ (see Fig. 1) and strength v=6:3₁, the transverse eigenvalues in the impurity region are solved by the quantum perturbation method as

$$_{1}^{0} = 0.23_{1}; \quad _{2}^{0} = 3.34_{1}$$
 (12)

with associated eigenfunctions $_1(y) = 0.951_1(y) = 0.314_2(y)$ and $_2(y) = 0.314_1(y) + 0.951_2(y)$. And different transverse eigenvalues as well as eigenfunctions can be obtained by variation of the impurity size.

In the following we system atically present some numerical examples, while restrict our attention to the energy range (1; 2) throughout the work.

A. The characteristics of transm ission dependence on incident energy

First of all, in the absence of the EM eld, the transm ission probability T as a function of incident energy E should be the same as that in Ref. [7], which shows the Berit-W inger resonances in the lower energies $_1$ < E < $_2^0$ and the multiple asymmetric Fano lines in the upper energies $_2^0$ < E < $_2$.

In the presence of the EM eld, we show the calculated T versus E for two combinations of the eld parameters in Fig. 2 with impurity size of d = 0.1D, l = 25, $y_c = 0.17D$ and strength v = 6.37. The dashed line presents the case of resonant eld frequency $! = 3.57 (= 0; ! = \frac{0}{2})$ with " = 9.96, while the solid line gives a representative case of nonresonant frequency! = 2(\(\) 0) with " = 2:97. In the case of the eld frequency resonant (m atching) with the energy spacing of the two lowest levels, the transmission probability is similar to that for the case of absent in purity 19 except for a suppression of average 0.1. A lso a step-raising of transm ission occurs at energy $E = {0 \atop 1} + {0 \atop 2} = 2.52$ (for these eld param eters the mode coupling constant = 5.5).²³ This interesting phenomenon can be similarly explained by the eld-induced intersubband transition. 9 W hen an electron penetrate though the interface, the transverse levels of the electron in the eld illum inated region are dressed and one electron mode is split into the two time-dependent m odes with the longitudinal momentum k_+ and k_- respectively. When E < 0 + 0 + 0 = 2, k_+ is imaginary and its corresponding mode is an evanescent (nonpropagating) mode which contributes nothing to the transmission so that the total transm ission probability is suppressed to an half value. Further, when E > 0 + 0 = 2 the both modes become propagating and all contribute to the transmission. However, with the non-resonant eld frequency the structure of transmission probability is much dierent from the case without impurity. For this case of non-resonant frequency and weaker eld amplitude we note that an interesting asymmetry Fano-type resonance dip appear at E indicates the form ation of a quasibound states. Electrons with this particular incident energy can make a transition from a propagating state to a quasibound state by emitting an energy of h!. So this resonance dip may be a result from the feature of the impurity-induced quasibound state. We can also explain this phenomenon with the mode propagational property. A round the point of E 2, from Eqs. (4) and (6) we not that the wavevector k_2 the eld-split electron wavevector k+ 0. This indicates that the two modes k_2 and k_\pm may be nonpropagating. So that T reaches a nonzero m in in um because k_1 and k are always propagating.

We also note that there are some resonance oscillations on the two transmission curves in Fig 2. These oscillations physically result from the interference of the forward-and backward-going electron waves induced by the two interfaces of the impurity along the transport direction. The resonance peaks with prefect transmission on the solid line of Fig. 2 appeared at lower energies E 1.01, 1.39 and 1.85 m ay be identified to the symmetry Breit-type resonance and the half width of each resonance specifies the lifetime of the corresponding quasibound state. Therefore, the above characteristics of T dependence on E for the system have implied the differences in electron transmission between the two cases of with and without in purity.

B. Transm ission dependence on the eld param eters

Next, in this subsection we investigate the in uence of the eld param eters on the electron transm ission with the interesting energy of E = 2 for the nonresonat frequency case (see Fig. 2). We present the numerically calculated T as a function of! and "as shown in Fig. 3 with the same impurity parameters as that in Fig. 2. From Fig. 3 we can see that the transm ission probability T changes between 0 (black) and 1 (white) with the variation of the eld parameters and shows several dip structures (black areas) around! 2, which includes the dip of the solid line in Fig. 2 at "3. We also note that there exist perfect transm ission areas (complete white). In the region of small "(regardless of the value of!) the eld is too weak to a ect the transm ission, while in the region of! > 3:57 (resonant) regardless of the value of "the eld-induced intersubbund transition dom inates. However, with the proper combinations of "and! perfect transm ission also occurs. This interesting phenomenon of perfect and blocked transm ission has also been predicted eld parameters.

In the following, we discuss the e ects of! and " on T separately. Fig.4 shows the calculated T as function of! for four di erent values of " with the same in purity parameters as that in Fig.2. In the case of a rather weak eld amplitude " = 1:5 as shown in Fig. 4(a), multiple Fano resonance lines appear within! = 1:69 1:82. This result is very similar to that in Ref.[7] but within the range of higher energies. From Eqs. (4) and (6), we know that in this case mode k_+ begins to open (propagating) earlier than k_2 with! 1:69 and " = 1:5 (= 1:75). There are two propagating modes (k_+) and (k_+) in the impurity region but only (k_+) is propagational outside the impurity. The multiple Fano resonances are connected with the interaction of multiple quasidonor levels but lowered by the EM eld. In Fig. 4(b) with " = 2:97 (same value as that in solid line of Fig. 2) there is only one Fano dip at! = 2, which corresponds to the single dip of the solid line in Fig. 2. Furtherm ore, as shown in Fig. 4(c) with stronger amplitude " = 6, T is suppressed with no dip in the range of (2.2) < 3 because the open of (k_+) enhances the probability of refection. And T increases when! > 3 due to the second mode (k_+) beginning to be propagating. So it is reasonable when only one mode (k_+) in the illuminated region with " = 10 is propagating and T is more suppressed as shown in Fig. 4(d).

On the other hand, in Fig. 5 we present the calculated T as function of " for four di erent values of! with the same in purity parameters. For a rather small! = 1 in Fig. 5(a) T shows an oscillation behavior with almost periodic maximum (perfect transmission) and declined minimum (valley) as "increases. The oscillation results from the interference of the forward—and backward—going electron waves induced by the two interfaces of the inpurity along the transport direction. With a xed! = 2, the multiple Fano resonance lines appear as shown in Fig. 5(b) within " = 0.8 2.6. The pattern of T is slightly dierent from that of Fig. 4(a) but with the same physical reason. The perfect transmissions are seen to occur at "= 0.78, 1.4, 1.68 and 2.3 and the asymmetric Fano dips are seen to occur at "= 0.8, 1.38, 1.82 ... The second mode (kis the evanescent mode and the coupling of the two modes in eld region vanishes as well as the formation of the quasibound states when " > 2.97 holds. From the above analysis it seems reasonable that the step structure appears around " = 3.4 in Fig. 5(c) with! = 2.3. This results from the suppression of the second mode (k+) with increasing of "when! > 2 holds. In Fig. 5(d) with! = 4 the average T is much enhanced with no dip or step structures because both k_+ and k_2 are propagating modes.

In general for a xed electron incident energy, a di erent com bination of the eld param eters results in a di erent transm ission dependence. But for the chosen geom etrical param eters in this work the rich structure of the transm ission always appear in the ranges of E 2,! 1:5 2 and " 1 3.

C. Transm ission dependence on the impurity parameters

Finally, in this subsection we investigate the e ects of the impurity parameters on the transmission probability T for the same system.

We rst consider the elect of impurity size on the transmission. An example of dierent impurity width d=0.2D has been adopted and its corresponding transverse eigenvalues have been calculated as $_1^0=1.85$ and $_2^0=3.19$. Fig. 6 shows the numerical results of T as a function of E with a xed !=2 for two dierent ". With "=2.97 the multiple Fano resonances appear in Fig. 6 (a) within a energy range of E = 1.6 1.8. However, Fig. 6 (b) shows that as "increases to 3.6 with the same!, a single Fano dip line (similar to the solid line in Fig. 2) appears. This indicates that the two modes (k_2 and k_+) begin to be propagating. Comparing with the solid line in Fig. 2 we conclude that as the width of the impurity increases, it need stronger eld amplitude "to suppress the splitting of the second mode. But this conclusion may not be extended to the increase of length 1.

Next, we consider the elect of the impurity strength on the transmission. An example of dierent impurity strength of v = 8.0 $_1$ has been adopted and its associated eigenvalues have been recalculated as $_1^0$ = 0.64 and $_2^0$ = 3.26. Fig. 7 shows the numerical results of T as a function of E with a xed! = 2 for two dierent". A asymmetry Fano dip

also occurs in Fig. 7(a) at E 1:9 (with " = 2:97) and in Fig. 7(b) at E 2 (with " = 3:2). From this result we conclude that with the same! although the increase of the impurity strength one need stronger eld amplitude" to suppress the splitting of the second mode. It seems that the variation of the impurity strength does not change the transmission behavior much even if we use a potential to model the impurity. And this fact of model independence is physically reasonable.

IV. CONCLUSION

We have theoretically investigated the electron transport properties for a straight sem iconductor quantum wire containing a single nite-size attractive impurity under a THzEM eldillum ination in the ballistic limit. Within the ective free-electron approximation, a single-particle time-dependent Schrodinger equation was established and the scattering matrix for the system was formulated via the method of time-dependent mode matching.

The numerical examples predicate that a step-arising on the transmission probability versus the electron incident energy occurs in the case of the eld frequency resonant with the lateral energy spacing of the two lowest levels. This situation is similar to the case of the system without 19 in purity and the physical origin is mainly the coherent eld-induced intersubband transition. However, due to the interplay between the impurity-induced quasibound states and the applied eld, both multiple symmetry Breit-type resonance peaks and asymmetry Fan-type diplines appear within the energy range of (1,2) in the case of a weaker eld amplitude and the non-resonant eld frequency. This situation is also consistent with the system 7 without eld illumination. Further, the dependence of the transmission on either eld amplitude or frequency also indicates the change of the shape and the position of the resonance dips. But the rich structure of the transmission always appears with the proper combination of the eld parameters. Moreover, the transmission behavior is almost independent on the impurity parameters.

Therefore, from the results of this work we conclude that the eld parameters! and "can control the characteristics of electron transm ission through the propagational property of the modes in a quantum wire. These elects of the applied eld on the transport properties in a quantum wire may be useful for understanding basic physics of quantum structures and for device physics.

A cknow ledgm ents

This work was supported by the Nature Science Foundation of Hunan (NO.02JJY 2008) and by the Research Foundation of Hunan Eduction Commission (NO.04A031).

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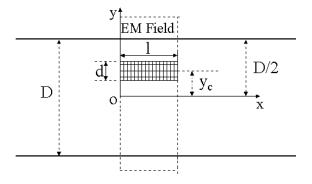
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- In the resonant case of = 0, with the system parameters selected in this work = 5.5. A coording to Eq. (6), $k_+ > 0$ requires that $E > \frac{0}{1} + = 2 = 2.52$.



 ${\tt F}\:{\tt IG}\:.1\hbox{:}\:{\tt Sketch}\:{\tt of}\:{\tt the}\:{\tt system}$

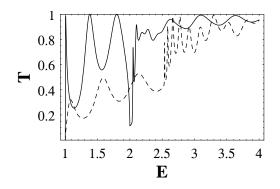


FIG. 2: Transm ission probability T dependence on the incident energy E (in units of $_1$) for two combinations of the eld parameters in the energy range ($_1$; $_2$), the dashed line for ! = 3:57 (= 0, resonant case) and " = 9:96, while the solid line for ! = 2 and " = 2:97. We have used the parameters of D = 200A, d = 0:1D, l = 25 and $_2$ = 0:17D such that $_1$ = 0:23 and $_2$ = 3:34.

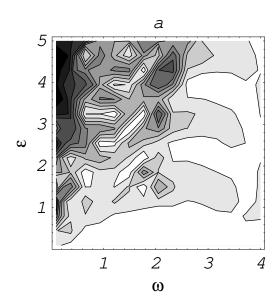


FIG. 3: Transm ission probability T dependence on both eld frequency! and amplitude "with incident energy E=2, the system parameters are the same as in Fig. 2.

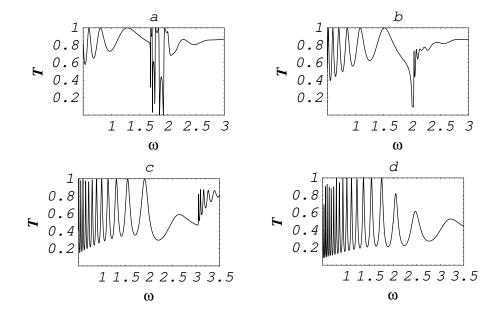


FIG. 4: Transm ission probability T dependence on eld frequency! with incident energy E=2 for serval eld amplitudes: (a) "= 1:5, (b) "= 2:97, (c) "= 6 and (d) "= 10. The system parameters are the same as in Fig. 2.

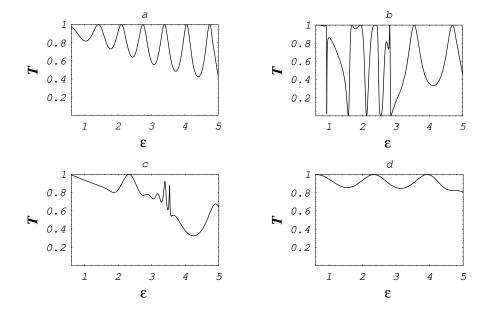
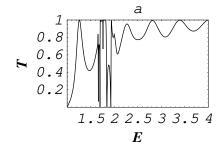


FIG.5: Transm ission probability T dependence on eld am plitude "with incident energy E = 2 for serval frequency: (a) ! = 1, (b) ! = 2, (c) ! = 2:3 and (d) ! = 4. The system param eters are the same as in Fig. 2.



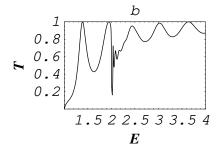
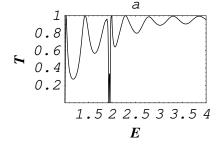


FIG. 6: Transm ission probability T dependence on incident energy E for a dierent impurity width of d=0.2D with eld frequency ! = 2: (a) " = 2:97 and (b) " = 3:6. W ith the same length land strength v as in Fig. 2 the change of the impurity width induces $_{1}^{0}$ = 1:85 and $_{2}^{0}$ = 3:19



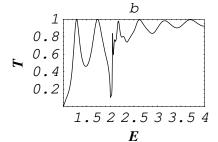


FIG. 7: Transm ission probability T dependence on incident energy E for a di erent in purity strength of v=8 with eld frequency ! = 2: (a) " = 2:97 and (b) " = 32. In this case 0_1 = 0:64 and 0_2 = 3.26 with the same in purity size as in Fig. 2.